

- **EPIC™ (Enhanced-Performance Implanted CMOS) 2-μ Process**
- **Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} , $T_A = 25^\circ\text{C}$**
- **Typical V_{OHV} (Output V_{OH} Undershoot) > 2 V at V_{CC} , $T_A = 25^\circ\text{C}$**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model ($C = 200$ pF, $R = 0$)**
- **Latch-Up Performance Exceeds 250 mA Per JEDEC Standard JESD-17**
- **Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Ceramic (J) 300-mil DIPs**

description

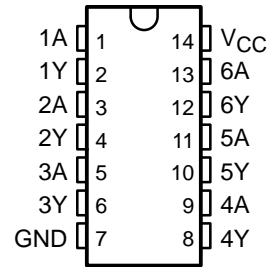
These hex inverters are designed for 2.7-V to 5.5-V V_{CC} operation.

The 'LV04 contain six independent inverters. These devices perform the Boolean function $Y = \bar{A}$.

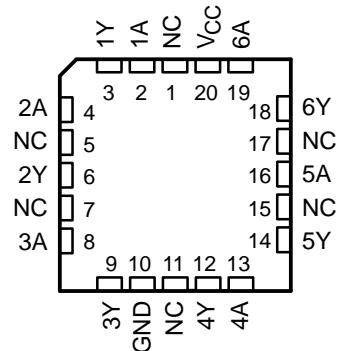
The SN74LV04 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54LV04 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74LV04 is characterized for operation from -40°C to 85°C .

**SN54LV04 . . . J OR W PACKAGE
SN74LV04 . . . D, DB, OR PW PACKAGE
(TOP VIEW)**



**SN54LV04 . . . FK PACKAGE
(TOP VIEW)**



NC – No internal connection

**FUNCTION TABLE
(each inverter)**

INPUT A	OUTPUT Y
H	L
L	H



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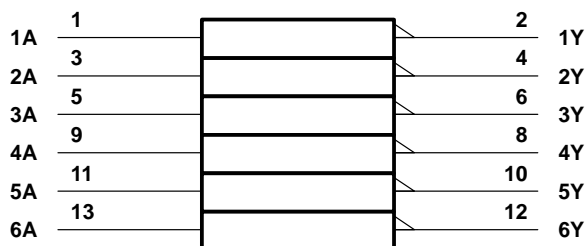
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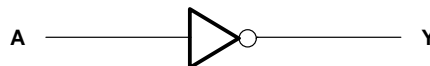
SN54LV04, SN74LV04 HEX INVERTERS

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logic symbol†



logic diagram, each inverter (positive logic)



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, DB, J, PW, and W packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Notes 1 and 2)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V_{CC} or GND	±50 mA
Maximum power dissipation at $T_A = 55^\circ\text{C}$ (in still air) (see Note 3): D package	1.25 W
DB or PW package	0.5 W
Storage temperature range, T_{stg}	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. This value is limited to 7 V maximum.
3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

recommended operating conditions (see Note 4)

			SN54LV04		SN74LV04		UNIT
			MIN	MAX	MIN	MAX	
V _{CC}	Supply voltage		2.7	5.5	2.7	5.5	V
V _{IH}	High-level input voltage	V _{CC} = 2.7 V to 3.6 V	2		2		V
		V _{CC} = 4.5 V to 5.5 V	3.15		3.15		
V _{IL}	Low-level input voltage	V _{CC} = 2.7 V to 3.6 V	0.8		0.8		V
		V _{CC} = 4.5 V to 5.5 V	1.65		1.65		
V _I	Input voltage		0	V _{CC}	0	V _{CC}	V
V _O	Output voltage		0	V _{CC}	0	V _{CC}	V
I _{OH}	High-level output current	V _{CC} = 2.7 V to 3.6 V	–6		–6		mA
		V _{CC} = 4.5 V to 5.5 V	–12		–12		
I _{OL}	Low-level output current	V _{CC} = 2.7 V to 3.6 V	6		6		mA
		V _{CC} = 4.5 V to 5.5 V	12		12		
Δt/Δv	Input transition rise or fall rate		0	100	0	100	ns/V
T _A	Operating free-air temperature		–55	125	–40	85	°C

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC} [†]	SN54LV04			SN74LV04			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V _{OH}	I _{OH} = –100 μA	MIN to MAX	V _{CC} –0.2			V _{CC} –0.2			V
	I _{OH} = –6 mA	3 V	2.4			2.4			
	I _{OH} = –12 mA	4.5 V	3.6			3.6			
V _{OL}	I _{OL} = 100 μA	MIN to MAX	0.2			0.2			V
	I _{OL} = 6 mA	3 V	0.4			0.4			
	I _{OL} = 12 mA	4.5 V	0.55			0.55			
I _I	V _I = V _{CC} or GND	3.6 V	±1			±1			μA
		5.5 V	±1			±1			
I _{CC}	V _I = V _{CC} or GND I _O = 0	3.6 V	20			20			μA
		5.5 V	20			20			
ΔI _{CC}	One input at V _{CC} – 0.6 V Other inputs at V _{CC} or GND	3 V to 3.6 V	500			500			μA
C _i	V _I = V _{CC} or GND	3.3 V	2.5			2.5			pF
		5 V	1.8			1.8			

[†] For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54LV04						UNIT
			V _{CC} = 5 V ± 0.5 V			V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V	
			MIN	TYP	MAX	MIN	TYP	MAX	
t _{pd}	A	Y	4	9		6	12	15	ns

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN74LV04						UNIT
			V _{CC} = 5 V ± 0.5 V			V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V	
			MIN	TYP	MAX	MIN	TYP	MAX	
t _{pd}	A	Y	4	9		6	12	15	ns

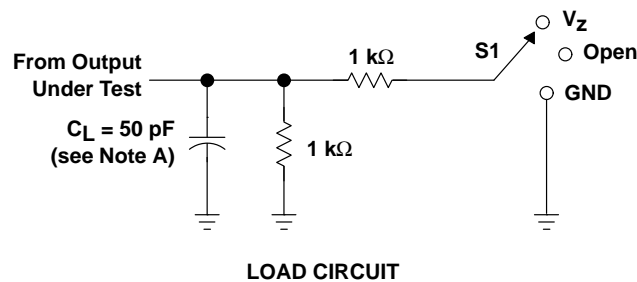
operating characteristics, T_A = 25°C

PARAMETER		TEST CONDITIONS	V _{CC}	TYP	UNIT
C _{pd}	Power dissipation capacitance per inverter	C _L = 50 pF, f = 10 MHz	3.3 V	18	pF
			5 V	26	

SN54LV04, SN74LV04
HEX INVERTERS

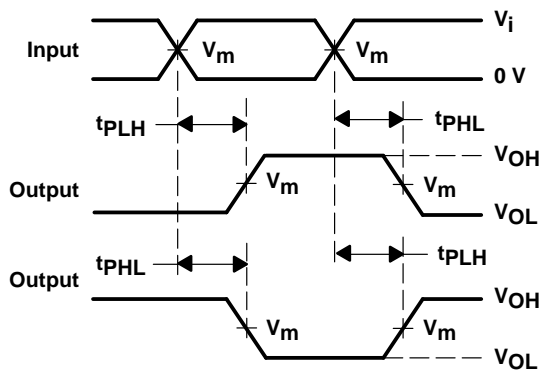
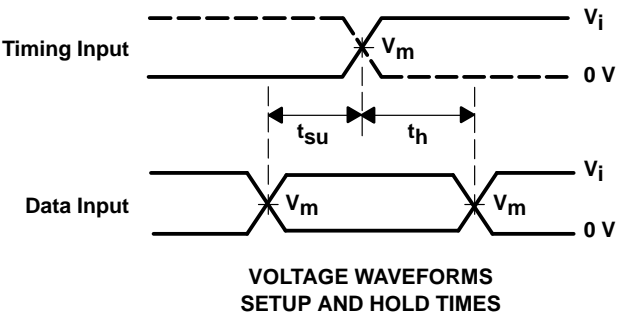
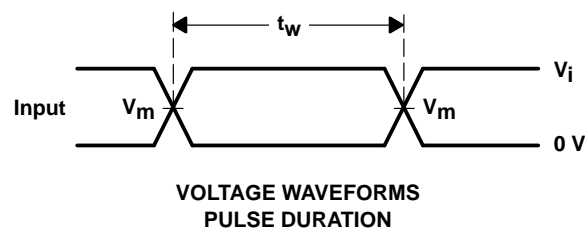
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PARAMETER MEASUREMENT INFORMATION

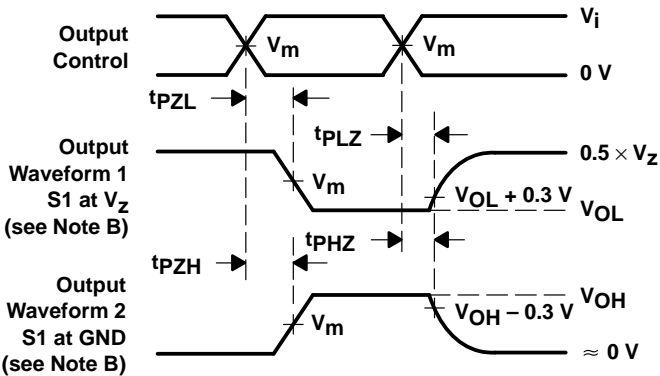


TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	V _Z
t _{PHZ} /t _{PZH}	GND

WAVEFORM CONDITION	V _{CC} = 4.5 V to 5.5 V	V _{CC} = 2.7 V to 3.6 V
V _m	0.5 × V _{CC}	1.5 V
V _i	V _{CC}	2.7 V
V _Z	2 × V _{CC}	6 V



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

- NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r ≤ 2.5 ns, t_f ≤ 2.5 ns.
D. The outputs are measured one at a time with one transition per measurement.
E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
F. t_{PZL} and t_{PZH} are the same as t_{en}.
G. t_{PLH} and t_{PHL} are the same as t_{pd}.

Figure 1. Load Circuit and Voltage Waveforms

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